Power MOSFET

30 V, 27 A, Single N-Channel, μ8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	7.7	Α
Current R _{θJA} (Note 1)		T _A = 85°C		5.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	1.63	W
Continuous Drain		T _A = 25°C	I _D	12.2	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 85°C		9.1	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	4.1	W
Continuous Drain	State	T _A = 25°C	I _D	5.0	Α
Current R _{θJA} (Note 2)		T _A = 85°C		3.8	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.69	W
Continuous Drain		T _C = 25°C	I _D	27	Α
Current R _{θJC} (Note 1)		T _C = 85°C		20	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	20.2	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I_{DM}	81	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to +150	°C
Source Current (Body Diode)			IS	17	Α
Drain to Source dV/dt			dV/dt	6.0	V/ns
Single Pulse Drain–to–Source Avalanche Energy (T_J = 25°C, V_{DD} = 50 V, V_{GS} = 10 V, I_L = 16 A_{pk} , L = 0.1 mH, R_G = 25 Ω) (Note 3)			E _{AS}	13	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum rating. Parts are 100% tested at $T_J=25^{\circ}C$, $V_{GS}=10$ V, $I_L=11$ Apk, $E_{AS}=6$ mJ.

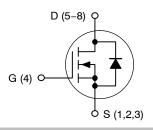


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX		
30 V	17 mΩ @ 10 V	27 A		
	26.5 mΩ @ 4.5 V	217		

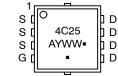
N-Channel MOSFET





CASE 511AB

MARKING DIAGRAM



4C25 = Specific Device Code
A = Assembly Location
Y - Year

Y = Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4C25NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS4C25NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	6.2	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	76.7	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	210	-C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{ heta JA}$	30.8	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

n Min Typ Max Unit	Test Condition		Parameter
			OFF CHARACTERISTICS
50 μA 30 V	V_{GS} = 0 V, I_D = 250 μA		Drain-to-Source Breakdown Voltage
= 4.4 A, = 100 ns	$V_{GS} = 0 \text{ V}, I_{D(aval)} = 4.4 \text{ A},$ $T_{case} = 25^{\circ}\text{C}, t_{transient} = 100 \text{ ns}$		Drain-to-Source Breakdown Voltage (transient)
15.3 mV/°C			Drain-to-Source Breakdown Voltage Temperature Coefficient
T _J = 25°C 1.0	V _{GS} = 0 V, T _J V _{DS} = 24 V	I _{DSS}	Zero Gate Voltage Drain Current
T _J = 125°C 10 μΑ	$V_{DS} = 24 V$ T_{J}	V _{DS} = 24	
±20 V ±100 nA	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20$	I _{GSS}	Gate-to-Source Leakage Current
			ON CHARACTERISTICS (Note 6)
50 μA 1.3 2.2 V	$V_{GS} = V_{DS}, I_D = 250$	V _{GS(TH)}	Gate Threshold Voltage
4.5 mV/°C		V _{GS(TH)} /T _J	Negative Threshold Temperature Coefficient
I _D = 10 A 13 17	V _{GS} = 10 V I _E	R _{DS(on)}	Drain-to-Source On Resistance
$I_D = 9 \text{ A}$ 21 26.5	V _{GS} = 4.5 V	,	
15 A 23 S	V _{DS} = 1.5 V, I _D = 15	9 _{FS}	Forward Transconductance
1.0 Ω	T _A = 25°C		Gate Resistance
			CHARGES AND CAPACITANCES
500	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V		Input Capacitance
V _{DS} = 15 V 295 pF			Output Capacitance
85			Reverse Transfer Capacitance
f = 1 MHz 0.170	V _{GS} = 0 V, V _{DS} = 15 V, f =	C _{RSS} /C _{ISS}	Capacitance Ratio
5.1		Q _{G(TOT)}	Total Gate Charge
0.9		Q _{G(TH)}	Threshold Gate Charge
V; I _D = 20 A 1.7 nC	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 20 \text{ A}$		Gate-to-Source Charge
2.7			Gate-to-Drain Charge
3.3 V			Gate Plateau Voltage
/; I _D = 20 A 10.3 nC	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 20 A		Total Gate Charge
			SWITCHING CHARACTERISTICS (Note 7)
8.0	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 10 \text{ A}, R_{G} = 3.0 \Omega$		Turn-On Delay Time
15 V, 32			Rise Time
3.0 Ω ns			Turn-Off Delay Time
3.0			Fall Time
3.0 Ω 10	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15$ $I_D = 10 \text{ A}, R_G = 3.0$	t _r t _{d(OFF)}	Turn-Off Delay Time

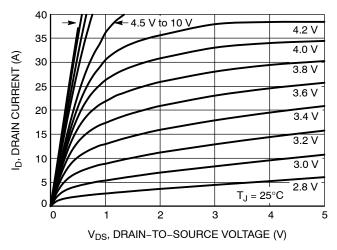
- 6. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 7)						
Turn-On Delay Time	t _{d(ON)}			4.0		ns	
Rise Time	t _r	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			25		
Turn-Off Delay Time	t _{d(OFF)}				13		
Fall Time	t _f				2.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V_{SD} $V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$		T _J = 25°C		0.87	1.2	
		I _S = 10 A T _J = 125°C	T _J = 125°C		0.75		- V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			18.2		
Charge Time	t _a				9.8		ns
Discharge Time	t _b				8.4		
Reverse Recovery Charge	Q_RR				5.7		nC

^{6.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.
7. Switching characteristics are independent of operating junction temperatures.

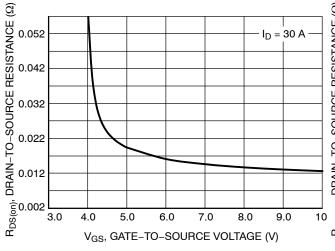
TYPICAL CHARACTERISTICS



 $V_{DS} = 5 V$ ID, DRAIN CURRENT (A) 30 20 $T_J = 125^{\circ}C$ 10 $T_J = 25^{\circ}C$ -55°C 0 0.5 1.0 1.5 2.0 2.5 3.0 3.5 4.0 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



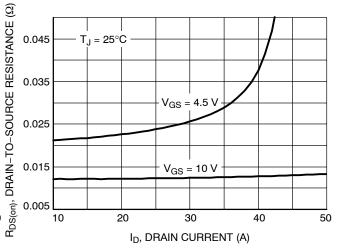
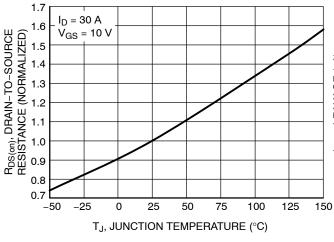


Figure 3. On-Resistance vs. V_{GS}

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



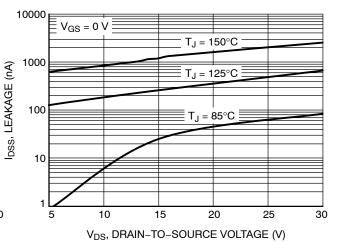


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

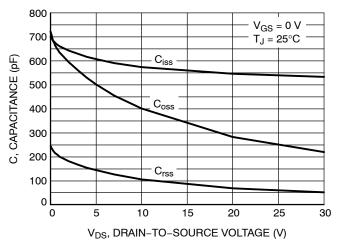


Figure 7. Capacitance Variation

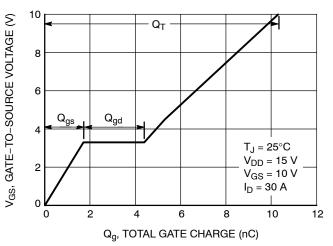


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

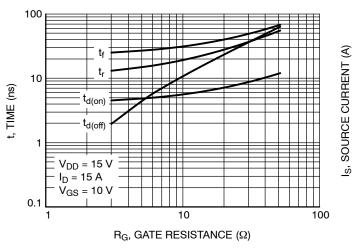


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

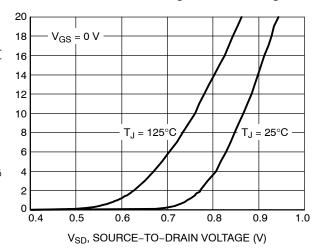


Figure 10. Diode Forward Voltage vs. Current

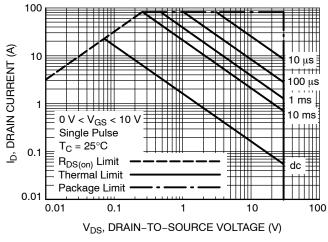


Figure 11. Maximum Rated Forward Biased Safe Operating Area

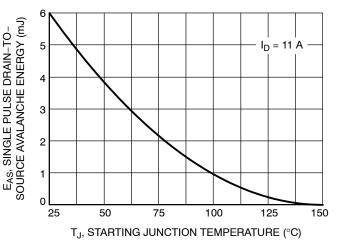


Figure 12. Maximum Avalanche Energy vs. **Starting Junction Temperature**

SINGLE PULSE DRAIN-TO-

TYPICAL CHARACTERISTICS

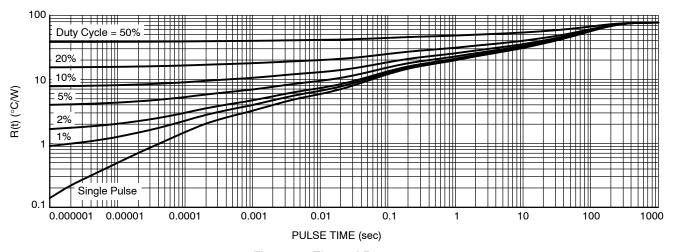


Figure 13. Thermal Response

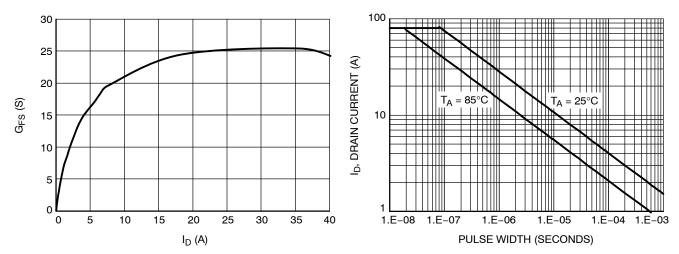
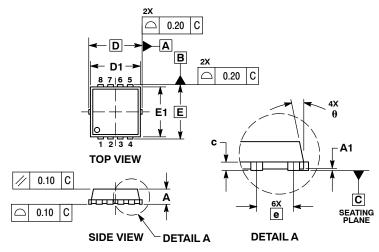


Figure 14. G_{FS} vs. I_D

Figure 15. Avalanche Characteristics

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

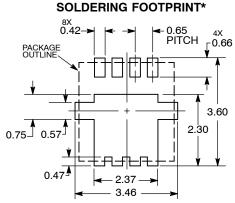


NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00	-	0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D	3.30 BSC			0.130 BSC		
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

С A B 0.10 0.05 С e/2 4X F3 D2 **BOTTOM VIEW**



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and was are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different application and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable afterney fees arising out of, directly or indirectly. its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

ON Semiconductor:

NTTFS4C65NTAG NTTFS4C65NTWG